COMPONENT SPECIFICATION

版次:第1.2版 MAX ECHO

| SMD WIRE WOUND CHIP INDUCTOR | COMPOSITE SPECIFICATION | 1/10 | HBWS-2012 | SPEC# | HBWS2012-SERIES | 10

1. SCOPE

This specification applies to the HBWS-2012 series SMD Wound Chip Inductor.

2. STANDARD ATMOSPHERIC CONDITIONS

Unless otherwise specified the standard range of atmospheric conditions for making measurements and tests is as follows:

Ambient temperature : $20\pm15^{\circ}$ C Relative humidity : $65\pm20\%$

If there may be any doubt on the results, measurements shall be made within

the following limits:

Ambient temperature : $25\pm5^{\circ}$ C Relative humidity : $75\pm10^{\circ}$

3. RATINGS

DART NO	INDUCTANCE	N/T 1	Q	DC RESISTANCE	Rated current	S.R.F
PART NO.	(nH)	**Tolerance	Min (Frequency)	(Ω) Max	(mA)max	Min(MHz)
HBWS2012-2N2	2.2@250MHz	±0.2nH,±0.3nH	50 (1000MHz)	0.060	800	6000
HBWS2012-2N7	2.7@250MHz	±0.2nH,±0.3nH	35 (1000MHz)	0.080	800	6000
HBWS2012-3N3	3.3@250MHz	±0.2nH,±0.3nH	60 (1000MHz)	0.080	800	6000
HBWS2012-3N9	3.9@250MHz	±0.2nH,±0.3nH	60 (1000MHz)	0.060	600	6000
HBWS2012-4N7	4.7@250MHz	±0.2nH,±0.3nH	60 (1000MHz)	0.060	600	5800
HBWS2012-5N1	5.1@250MHz	±0.2nH,±5%,±10%	60 (1000MHz)	0.080	600	5800
HBWS2012-5N6	5.6@250MHz	±0.2nH,±5%,±10%	60 (1000MHz)	0.080	600	5500
HBWS2012-6N8	6.8@250MHz	±0.2nH,±5%,±10%	60 (1000MHz)	0.060	600	5500
HBWS2012-8N2	8.2@250MHz	±0.2nH,±5%,±10%	60 (1000MHz)	0.060	600	4800
HBWS2012-10N	10@250MHz	±2%,±5%,±10%	60 (500MHz)	0.080	600	4100
HBWS2012-12N	12@250MHz	±2%,±5%,±10%	60 (500MHz)	0.080	600	3600
HBWS2012-15N	15@250MHz	±2%,±5%,±10%	60 (500MHz)	0.080	600	3400
HBWS2012-18N	18@250MHz	±2%,±5%,±10%	60 (500MHz)	0.080	600	3300
HBWS2012-22N	22@250MHz	±2%,±5%,±10%	60 (500MHz)	0.100	600	2600
HBWS2012-27N	27@250MHz	±2%,±5%,±10%	60 (500MHz)	0.120	600	2400
HBWS2012-33N	33@250MHz	±2%,±5%,±10%	60 (500MHz)	0.150	500	2100
HBWS2012-39N	39@250MHz	±2%,±5%,±10%	60 (500MHz)	0.180	500	1700
HBWS2012-47N	47@200MHz	±2%,±5%,±10%	60 (500MHz)	0.150	500	1600
HBWS2012-56N	56@200MHz	±2%,±5%,±10%	60 (500MHz)	0.250	500	1450
HBWS2012-68N	68@200MHz	±2%,±5%,±10%	60 (500MHz)	0.270	500	1350
HBWS2012-82N	82@150MHz	±2%,±5%,±10%	60 (500MHz)	0.320	500	1200
HBWS2012-R10	100@150MHz	±2%,±5%,±10%	60 (500MHz)	0.430	500	1100
HBWS2012-R12	120@150MHz	±2%,±5%,±10%	50 (250MHz)	0.480	500	950
HBWS2012-R15	150@100MHz	±2%,±5%,±10%	50 (250MHz)	0.560	400	900

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MAX ECHO 版次:第1.2版 SMD WIRE WOUND CHIP INDUCTOR COMPOSITE SPECIFICATION A M HBWS-2012 SPEC# HBWS2012-SERIES Е INDUCTANCE DC RESISTANCE Rated current S.R.F Q PART NO. ★Tolerance (nH) Min (Frequency (Ω) Max (mA)max Min(MHz) HBWS2012-R18 180@100MHz ±2%,±5%,±10% 0.78 900 50 (250MHz) 400 HBWS2012-R22 220@100MHz ±2%,±5%,±10% 50 (250MHz) 1 400 860 HBWS2012-R27 270@100MHz ±2%,±5%,±10% 45 (250MHz) 1.46 350 850 HBWS2012-R33 330@100MHz ±2%,±5%,±10% 45 (250MHz) 1.65 300 800 HBWS2012-R39 390@100MHz ±2%,±5%,±10% 45 (250MHz) 2.2 210 780

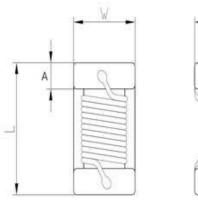
 [★] B:±0.2nH S:±0.3nH K:±10% J:±5% G:±2%

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4. DIMENSION





OPERATING TEMP. RANGE: -40° C $\sim +125^{\circ}$ C STORAGE TEMP. RANGE: -10° C $\sim +40^{\circ}$ C TYPE L W T A

			_	
HBWS-2012	2.00±0.20	1.25±0.25	1.20±0.20	0.3~0.5
	(.080±.008)	(.050±.010)	(.047±.008)	(0.012~0.02)

5. The place of origin: Taichung, Taiwan

HISTORY	DATE		REVISION	SIGN.	SIGN.
PLANNED BY	CHECKED BY	APPROVED BY		1 1.	
Marco	LUN	Tina Hsu		il文件中 發行章	(3)

COMPONENT SPECIFICATION

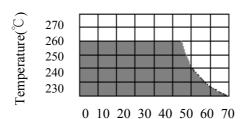
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Reflow soldering conditions

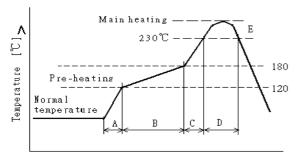
Pre—heating should be in such a way that the temperature difference between solder and ceramic surface is limited to 150°C max. Also cooling into solvent after soldering should be in such a way that the temperature difference is limited to 100°C max.

Insufficient pre—heating may cause cracks on the ceramic, resulting in the deterioration of product quality.

Products should be soldered within the following allowable range indicated by the slanted line. The excessive soldering conditions may cause the corrosion of the electrode, when soldering is repeated, allowable time is the accumulated time.



Temperature Profile



Α	Slope of temp. rise	1 to 5	°C/sec
В	Heat time	50 to 150	sec
ь	Heat temperature	120 to 180	$^{\circ}\!\mathbb{C}$
С	Slope of temp. rise	1 to 5	°C/sec
D	Time over 230°C	90~120	sec
Е	Peak temperature	255~260	$^{\circ}\!\mathbb{C}$
E	Peak hold time	10 max.	sec
	No. of mounting	3	times

Time [sec] (Metting area of solder)

Reworking with soldering iron

, , , , , , , , , , , , , , , , , , ,	
Preheating	150°C, 1 minute
Tip temperature	280°C max.
Soldering time	3 seconds max.
Soldering iron output	30w max.
End of soldering iron	f 3mm max.

Reworking should be limited to only one time.

Note: Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the ferrite material due to the thermal shock.

Solder Volume Solder shall be used not to be exceed the upper limits as shown below. Recommendable

When the amount of solder volume increased, mechanical stress increased as well. Exceeding amount of solder volume may lead to failure of mechanical or electronical characteristics.

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HBWS-2012

SPEC# HBWS2012-SERIES

Mechanical Characteristics

ITEM	CONDITION	SPECIFICATION
Inductance and Tolerance	Measuring Frequency : As shown in Product Table	Within Specified Tolerance
Quality Factor	Measuring Temperature: + 25 °C	
Insulation Resistance	Measured at 100V DC between inductor terminals and center of case.	1000 mega ohms minimum

Electrical Characteristics

ITEM	CONDITION	SPECIFICATION
Component Adhesion	The component shall be reflow	0402 series - ≥350g
(Push Test)	soldered onto a P. C. Board	0603 series - ≥1.0Kg
	($240 ^{\circ}\text{C} \pm 5 ^{\circ}\text{C}$ for 20seconds).	Other series - 2012 ~ 3225
	Then a dynometer force gauge shall	Minimum 1Kg for Pd/Ag
	be applied to any side of the	termination and 2Kg for Mo/Mn
	component.	
Drop Test	The inductor shall be dropped	Change In Inductance:
	two times on the concrete floor	No more than 5%
	or the vinyl tile from 1M naturally.	
Thermal Shock Test	Each cycle shall consist of 30 minutes at	Change In Q:
	-40 °C followed by 30 minutes at +85 °C	No more than 10%
	with a 20-second maximum transition	
	time between temperature extremes.	Change In Appearance:
	Test duration is 10 cycles.	Without distinct damage
Substrate Bending Test	_	9 1
	shall meet specifications.	substrate, bend the substrate by 3mm
		hold for 10s and then return.
		Soldering shall be done in
		accordance with the recommended
		PC board pattern and reflow soldering.
		soldering.
		unit : mm

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Endurance Characteristics

ITEM	CONDITION	SPECIFICATION
Solderability	Dip pads in flux and dip in solder pot	A minimum of 80% of the metalized
	containing lead free solder at	area must be covered with solder.
	$240 ^{\circ}\text{C} \pm 5 ^{\circ}\text{C}$ for 5 seconds.	
Resistance to Soldering Hea	Dip the components into flux and dip	Change In Inductance:
	into solder pot containing lead free solder	No more than 5%
	at 260 °C \pm 5 °C for 5 \pm 2 seconds.	
Vibration (Random)	Inductors shall be randomly vibrated at	Change In Q:No more than 10%
	amplitude of 1.5mm and frequency of	
	10 - 55 Hz: 0.04 G / Hz for a minimum	
	of 15 minutes per axis for each of the	
	three axes.	
Cold Temperature Storage	Inductors shall be stored at temperature	Change In Appearance :
	of -40 °C \pm 2 °C for 1000hrs (+ 48 -0hrs.)	Without distinct damage
	Then inductors shall be subjected to	
	standard atmospheric conditions for 1 hour	
	After that, measurement shall be made.	
High Temperature Storage	Inductors shall be stored at temperature	
	of $85 ^{\circ}\text{C} \pm 2 ^{\circ}\text{C}$ for $1000 \text{hrs} (+48 - 0 \text{hrs.})$	
	Then inductors shall be subjected to	
	standard atmospheric conditions	
	for 1 hour.	
	After that, measurement shall be made.	
Moisture Resistance	Inductors shall be stored in the chamber at	
	45 °C at 90 - 95 R. H. for 1000 hours.	or open winding.
	Then inductors are to be tested after	
	2 hours at room temperature.	
High Temperature	Inductors shall be stored in the chamber	
with Loaded	at +85 °C for 1000 hours with rated	
	current applied. Inductors shall be tested	
	at the beginning of test at 500 hours and	
	1000 hours.	
	Then inductors are to be tested after	
	1 hour at room temperature.	

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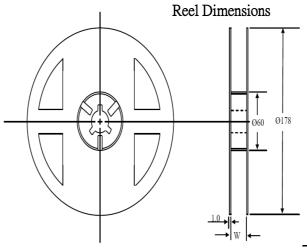
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SMD WIRE WOUND CHIP INDUCTOR | COMPONENT SPECIFICATION Name **HBWS-2012**

SPEC# HBWS2012-SERIES

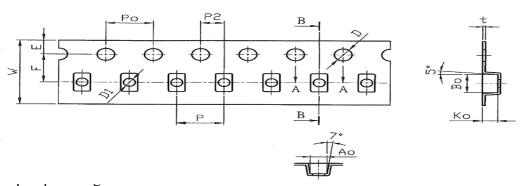
Packaging Information

TYPE	PCS / REEL
HBWS 1005	10,000
HBWS 1608	3,000
HBWS 2012	2,000
HBWS 2520	2,000

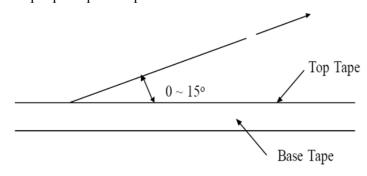


Tape Dimensions (unit:m

Size						CAK	KIEK							
Size	Ao	Во	Ko	t	D	D1		Е	F	P	Po	P2	W	Unit
1005	0.62±0.05	1.12±0.05	NA	0.60±0.05	1.55±0.05	NA		1.75±0.10	3.50±0.05	2.00±0.05	4.00±0.10	NA	8.00±0.10	mm
1608	1.40±0.1	1.90±0.1	1.15±0.1	0.23±0.05	1.50+0.10/-0.00	0.60±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm
2012	1.42±0.1	2.26±0.1	1.30±0.1	0.23±0.05	1.50+0.10/-0.00	0.70±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm
2520	2.20±0.1	2.83±0.1	1.75±0.1	0.22±0.05	1.50+0.10/-0.00	1.00±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm



The top tape requires a peel-off force of 0.2 to 0.7N in the direction of the arrow as illustrated below.

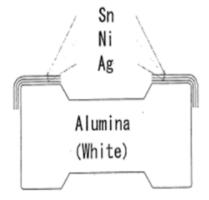


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3.7	SMD WIRE WOUND CHIP INDUCTOR	COMPO	NENT SPECIFICATION	8/
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Ingredient of terminals electrode.



Ceramic Type Sn Nickel Ag

Срегации вичнини

Do not use this product under the following environmental conditions, on deterioration of performance, such as insulation resistance may result from the use.

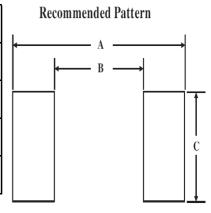
- 1. In corrosive gases (acidic gases, alkaline gases, chlorine, sulfur gases, organic gases and etc.)
- 2. In the atmosphere where liquid such as organic solvent, may splash on the products.

Delivery

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

Pattern Dimensions (unit:m/m)

Metric (EIA)	A mm	B mm	C mm
Wietiic (EIA)	(inches)	(inches)	(inches)
1005 (0402)	1.20	0.45	0.65
1003 (0402)	(0.047)	(0.018)	(0.026)
1608 (0603)	1.90	0.65	1.00
1008 (0003)	(0.075)	(0.026)	(0.039)
2012 (0805)	2.60	0.75	1.30
2012 (0803)	(0.102)	(0.030)	(0.051)
2520 (1008)	3.00	1.20	2.20
2320 (1008)	(0.118)	(0.047)	(0.087)



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Name SMD WIRE WOUND CHIP INDUCTOR COMPONENT SPECIFICATION HBWS-2012 SPEC# HBWS2012-SERIES 10
Peeling Strength Of Cover Tape

Peeling Strength Of Cover Tape

Cover tape

165°~180°

(10g~100g)

Test condition

1. peel angle: 165°~180° vs carrier tape

2. peel speed: 300mm/min

Packaging

1) Tape & Reel packaging in component specification 5/8

2) Reel and a bag of desiccant shall be packed in Nylon or plastic bag

3) Maximum of 5 reels shall be packaged in a inner box

4) Maximum of 6 inner box shall be packaged in a outer box

Reel Label

Producing the goods label needs to indicate (1) Pb Free (2) RoHS Compliant

表格編號:034承認書 A

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Name	SMD WIRE WOUND CHIP INDUCTOR	COMPONENT SPECIFICATION		10⁄
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Storage

- 1. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Packages must be stored at 40°C or less and 70% RH or less.
- 2. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust or harmful gas (hydrogen chloride, sulfurous acid gas or hydrogen sulfide).
- 3. Packaging material may be deformed if packages are stored where they are exposed to heat or direct sun—light.
- 4. Minimum packages, such as polyvinyl heat—seal packages shall not be opened until just before they are used.

 If opened, use the reels as soon as possible.
- 5. Solderability specified in component specification 4/8 shall be for 12 months from the date of delivery on condition that they are stored at the environment specified clause 13-1 & 13-2.

For those parts which passed more than 12 months shall be checked solderability before it is used.

Quality System

- ISO/IATF16949
- IECQ QC 080000

表格編號:034承認書 A